**1.Scope** This specifies Fuji Power MOSFET FMH09N90G

2.Construction N-Channel enhancement mode power MOSFET

**3.Applications** for Switching

**4.Outview** TO-3P Outview See to 8/18 page

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## 5. Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain Course Valtage	V <sub>DS</sub>	900	VV	
Drain-Source Voltage	V <sub>DSX</sub>	900	VIV	VGS=-30V
Continuous Drain Current	I <sub>D</sub> .TV	± 9	CA.T	
Pulsed Drain Current	I <sub>DP</sub>	± 36	AM	
Gate-Source Voltage	$V_{GS}$	± 30	MOV	
Repetitive and Non-repetitive Maximum Avalanche Current	I <sub>AR</sub>	9 9 1 1 1	ON A CO	Note *1
Non-Repetitive Maximum Avalanche Energy	E <sub>AS</sub>	647.2	mJ	Note *2
Repetitive Maximum Avalanche Energy	E <sub>AR</sub>	15.5	mJ	Note *3
Maximum Drain-Source dV/dt	dV <sub>DS</sub> /dt	40	kV/μs	VDS≤900V
Peak Diode Recovery dV/dt	dV/dt	M.TW 5	kV/μs	Note *4
Maximum Dawar Dissination	DV.100Y.C	155	WW 10	Tc=25°C
Maximum Power Dissipation	Po	2.50	N N VV	Ta=25°C
Operating and Storage	T <sub>ch</sub>	150	°C	John COMIL
Temperature range	T <sub>stg</sub>	-55 to +150	°C	V.Too.

# 6.Electrical Characteristics at Tc=25°C (unless otherwise specified) Static Ratings

Description	Symbol	Cond	ditions	min.	typ.	max.	Unit
Drain-Source	MITW	I <sub>D</sub> =250μA	AN.1001.	OM:I	N .	MWW.10	NY.CO
Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V	MM:100 1.	900		WYW.1	VC
Gate Threshold	$CO_{M-1}$	I <sub>D</sub> =250μA	MM.Ing	COM.	TW	WWW	OOY.
Voltage	V <sub>GS</sub> (th)	$V_{DS}=V_{GS}$	M.100	3.0	T V	5.0	V
Zero Gate Voltage	Y.COM.	$V_{DS}$ =900V $V_{GS}$ =0V	T <sub>ch</sub> =25°C	OX.CON	M.T.W	25	M:100
Drain Current	I <sub>DSS</sub>	$V_{DS}$ =720V $V_{GS}$ =0V	T <sub>ch</sub> =125°C	TOOX.CO	MIW	250	μА
Gate-Source	CO CO	$V_{GS} = \pm 30V$	MMA	100X.C		1	WW.
Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V	WW	100Y	$CO_{MT}$	100	nA
Drain-Source	1.100Y.	I <sub>D</sub> =4.5A	W	100	I.Co.	N	MM
On-State Resistance	R <sub>DS</sub> (on)	V <sub>GS</sub> =10V	V W	7 10	1.22	1.58	Ω

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### **Dynamic Ratings**

Description	Symbol	Conditions	min.	typ.	max.	Unit
Forward	WTWO	I <sub>D</sub> =4.5A	COMITY			
Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =25V	5	10	-	S
Input Capacitance	Ciss	V <sub>DS</sub> =25V	T. COM.	1100	1650	
Output Capacitance	Coss	V <sub>GS</sub> =0V	ON CON	140	210	
Reverse Transfer	ON.CON	f=1MHz	OON.CO	8	12	pF
Capacitance	Crss CO	MWW WWW	1100-X.C.C			
WWW WITH	td(on)	V <sub>cc</sub> =600V	VI 100Y.C	25	38	
Turn-On Time	tr 1001.	V <sub>GS</sub> =10V	11.100X	12	18	1
ON.TW WW	td(off)	I <sub>D</sub> =4.5A	MN-100	50	75	ns
Turn-Off Time	tf100	$R_{GS}=10\Omega$	WW-100	12)	18	1
Total Gate Charge	$Q_G$	V <sub>cc</sub> =450V	WALM'TO	31	46.5	
Gate-Source Charge	$Q_{GS}$	I <sub>D</sub> =9A	WAIN.	9.CO	13.5	nC
Gate-Drain Charge	$Q_{GD}$	V <sub>GS</sub> =10V	WINN	11/.C	16.5	1

#### **Reverse Diode**

Description	Symbol	Conditions	min.	typ.	max.	Unit
Diode Forward	W	I <sub>F</sub> =9A	T.	W 100	Y.COM	IM
On-Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V T <sub>ch</sub> =25°C	<u>-</u>	0.90	1.50	V
Reverse Recovery		I <sub>F</sub> =9A	W.	WW.	On x.	Will
Time	trr	V <sub>GS</sub> =0V	LM.	3.2	.100 1.	μs
Reverse Recovery	TW	-di/dt=100A/μs	TW	WW	1.100 X.	OM
Charge	Qrr	T <sub>ch</sub> =25°C	VI.	15.5	W.100Y	μС

## 7.Thermal Resistance

Description	Symbol	min.	typ.	max.	Unit
Channel to Case	Rth(ch-c)	OOT.CO.	N	0.806	°C/W
Channel to Ambient	Rth(ch-a)	TONY COM	L/N	50.0	°C/W

Note \*1 : Tch≤150°C, See Fig.1 and Fig.2

Note \*2 : Starting Tch= $25^{\circ}$ C,I<sub>AS</sub>=4A,L=74.2mH,Vcc=90V,R<sub>G</sub>= $50\,\Omega$ ,See Fig.1 and Fig.2 E<sub>AS</sub> limited by maximum channel temperature and avalanche current. See to the 'Maximum Avalanche Energy' graph of page 17/18.

Note \*3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Maximum Transient Thermal impedance' graph of page 18/18.

Note \*4 :  $I_F \le -I_D$ ,  $-di/dt = 50A/\mu s$ ,  $Vcc \le BV_{DSS}$ ,  $Tch \le 150$ °C

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料 886-3-5753170 力材 胜特力电子(上海) 86-21-34970699 胜特力电子(深圳) 86-755-83298787 Fig.1 Test circuit Http://www. 100y. com. tw WWW.100Y.COM.TW 000 D.U.T 50Ω Vcc This material and the information herein is the property of Fuji Electric Device Technology Co.,Ltd. They shall be neither reproduced, copied, lent, or isclosed in any way whatsoever for the use of any third party nor used for the manufacturing purposes without the express written consent of Fuji Electric Device Technology Co.,Ltd. Fig.2 Operating waveforms +10V Vgs -15V -WWW.100 WWW.100Y.COM. **BV**<sub>DSS</sub> WW.tony. IDP **V**DS ID WWW.100Y.CO

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All guaranteed values are under the categories of reliability per non-assembled(only MOSFETs). Each categories under the guaranteed reliability conform to EIAJ ED4701/100 method104 standards.

Test items required without fail

Humidification treatment (85±2°C,65±5%RH,168±24hr)

Heat treatment of soldering (Solder Dipping,260±5°C(265°Cmax.),10±1sec,2 times)

TW	Test No.	Test Items	Testing methods and Conditions	Reference Standard	Sampling number	Acceptance number
CON CON	N 1 TW LTW M.TW	Terminal Strength (Tensile)	Pull force TO-220,TO-220F: 10N TO-3P,TO-3PF,TO-247: 25N TO-3PL: 45N T-Pack,K-Pack: 10N Force maintaining duration: 30±5sec	EIAJ ED4701/400 method 401	ATW 15	
spo	2 Terminal Load Strength TO-2 (Bending) TO-3 T-Pa		Load force TO-220,TO-220F: 5N TO-3P,TO-3PF,TO-247: 10N TO-3PL: 15N T-Pack,K-Pack: 5N Number of times: 2times(90deg./time)	EIAJ ED4701/400 method 401	ED4701/400 15	
Mechanical test methods	7. C 07. C	Mounting Strength	Screwing torque value: (M3) TO-220,TO-220F: 40±10N·cm TO-3P,TO-3PF,TO-247: 50±10N·cm TO-3PL: 70±10N·cm	EIAJ ED4701/400 method 402	15	(0:1)
Mechanic	V.100°4	Vibration	frequency: 100Hz to 2kHz Acceleration: 200m/s² Sweeping time: 4min. 48min. for each X,Y&Z directions.	EIAJ ED4701/400 method 403	15	OM.TW OM.TW
W	5	Shock	Peak amplitude: 15km/s <sup>2</sup> Duration time: 0.5ms 3times for each X,Y&Z directions.	EIAJ ED4701/400 method 404	15	COM.TW
	6	Solderability	Solder temp.: 245±5°C Immersion time: 5±0.5sec Each terminal shall be immersed in the solder bath within 1 to 1.5mm from the body.	LTW M.T <sup>W</sup> OM.TW	15	100X.COM
	7	Resistance to Soldering Heat	Solder temp. : 260±5°C Immersion time : 10±1sec Number of times : 1times	EIAJ ED4701/300 method 302	15	M.100X.C

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Sampling

Acceptance

Reference

	No.	Items	Tooling motificate and Conditions	Standard	number	number
1	W <sup>1</sup>	High Temp. Storage	Temperature : 150+0/-5°C Test duration : 1000hr	EIAJ ED4701/200 method 201	22	
		Low Temp. Storage	Temperature : -55+5/-0°C Test duration : 1000hr	EIAJ ED4701/200 method 202	22	
sp	3	Temperature Humidity Storage	Temperature: 85±2°C Relative humidity: 85±5% Test duration: 1000hr	EIAJ ED4701/100 method 103	22	
Climatic test methods		Temperature Humidity BIAS	Temperature: 85±2°C Relative humidity: 85±5% Bias Voltage: V <sub>DS</sub> (max) * 0.8 Test duration: 1000hr	EIAJ ED4701/100 method 103	22	
Climatic	5	Unsaturated Pressurized Vapor	Temperature: 130±2°C Relative humidity: 85±5% Vapor pressure: 230kPa Test duration: 48hr	EIAJ ED4701/100 method 103	OM.TW 22	(0:1)
	CON 6	Temperature Cycle	High temp.side: 150±5°C/30min.  Low temp.side: -55±5°C/30min.  RT: 5°C ~ 35°C/5min.  Number of cycles: 100cycles	EIAJ ED4701/100 method 105	COM TE	N
	7 107.C 1007.C	Thermal Shock	Fluid: pure water(running water) High temp.side: 100+0/-5°C Low temp.side: 0+5/-0°C Duration time: HT 5min,LT 5min Number of cycles: 100cycles	EIAJ ED4701/300 method 307	22	TW LTW M.TW
nethods	100	Intermittent Operating Life	∆Tc=90degree Tch≤Tch(max.) Test duration : 3000 cycle	EIAJ ED4701/100 method 106	22	OM.TW
ndurance test methods	9	HTRB (Gate-source)	Temperature: Tch=150+0/-5°C Bias Voltage: +V <sub>GS</sub> (max) Test duration: 1000hr	EIAJ ED4701/100 method 101	22	(0:1)
ndurar	10	HTRB (Drain-Source)	Temperature : Tch=150+0/-5°C Bias Voltage : V <sub>DS</sub> (max) * 0.8	EIAJ ED4701/100	22	Y.COM.

Testing methods and Conditions

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Test

Test

ltem N		Symbols	Failure	Unit	
		V 100Y	Lower Limit	Upper Limit	5
- 10	Breakdown Voltage	BVDSS	LSL	W.W.	V
Electrical aracteristics	Zero gate Voltage Drain-Source Current	IDSS	N.Cos-	USL	A
Electrical aracterist	Gate-Source Leakage Current	IGSS	N.CONT.	USL	Α
cte	Gate Threshold Voltage	VGS(th)	LSL	USL	V
Ele ara	Drain-Source on-state Resistance	RDS(on)	1001 TANTAN	USL	Ω
S	Forward Transconductance	gfs	LSL		S
	Diode forward on-Voltage	VSD	CON CONT	V USL	V
ew	Marking		A Tran COM.	TI III	1111
Outview	Soldering		With eyes or Microscope		
õ	and other damages	M.			

Test duration: 1000hr

method 101

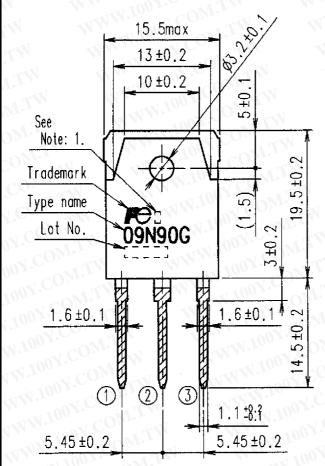
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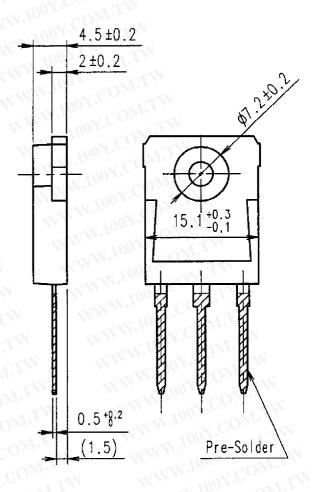
<sup>\*</sup> LSL : Lower Specification Limit \* USL : Upper Specification Limit

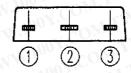
<sup>\*</sup> Before any of electrical characteristics measure, all testing related to the humidity have conducted after drying the package surface for more than an hour at 150°C.

## POWER MOS

# FMH09N90G[]







Note: 1.Country of origin mark. No mark is Made in JAPAN. FP1 is Made in PHILIPPINES.

# CONNECTION

- GATE
- DRAIN
- SOURCE

: SC-65 ETAJ

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#### 9. Cautions

- Although Fuji Electric is continually improving product quality and reliability, a small percentage of semiconductor products may become faulty. When using Fuji Electric semiconductor products in your equipment, you are requested to take adequate safety measures to prevent the equipment from causing physical injury, fire, or other problem in case any of the products fail. It is recommended to make your design fail-safe, flame retardant, and free of malfunction.
- The products described in this Specification are intended for use in the following electronic and electrical equipment which has normal reliability requirements.

Computers

OA equipment

Communications equipment(Terminal devices)

· Machine tools

AV equipment

· Measurement equipment

Personal equipment

· Industrial robots

- · Electrical home appliances etc.
- The products described in this Specification are not designed or manufactured to be used in equipment or systems used under life-threatening situations. If you are considering using these products in the equipment listed below, first check the system construction and required reliability, and take adequate safety measures such as a backup system to prevent the equipment from malfunctioning.

· Backbone network equipment

· Transportation equipment (automobiles, trains, ships, etc.)

· Traffic-signal control equipment

· Gas alarms, leakage gas auto breakers

· Submarine repeater equipment

· Burglar alarms, fire alarms, emergency equipment

· Medical equipment

- · Nuclear control equipment etc.
- Do not use the products in this Specification for equipment requiring strict reliability such as(but not limited to):

· Aerospace equipment

Aeronautical equipment

#### 10. Warnings

- The MOSFETs should be used in products within their absolute maximum rating(voltage, current, temperature, etc.).
- The MOSFETs may be destroyed if used beyond the rating.
- We only guarantee the non-repetitive Avalanche capability and not for the continuous Avalanche capability
  which can be assumed as abnormal condition .Please note the device may be destructed from the
  Avalanche over the specified maximum rating.
- The equipment containing MOSFETs should have adequate fuses or circuit breakers to prevent the equipment from causing secondary destruction (ex. fire, explosion etc...).
- Use the MOSFETs within their reliability and lifetime under certain environments or conditions. The MOSFETs may fail before the target lifetime of your products if used under certain reliability conditions.
- · Be careful when handling MOSFETs for ESD damage. (It is an important consideration.)
- · When handling MOSFETs, hold them by the case (package) and don't touch the leads and terminals.
- It is recommended that any handling of MOSFETs is done on grounded electrically conductive floor and tablemats.

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- · Before touching a MOSFET terminal, Discharge any static electricity from your body and clothes by grounding out through a high impedance resistor (about  $1M\Omega$ )
  - When soldering, in order to protect the MOSFETs from static electricity, ground the soldering iron or soldering bath through a low impedance resistor.
  - You must design the MOSFETs to be operated within the specified maximum ratings(voltage, current, temperature, etc.) to prevent possible failure or destruction of devices.
  - Consider the possible temperature rise not only for the channel and case, but also for the outer
  - Do not directly touch the leads or package of the MOSFETs while power is supplied or during operation in order to avoid electric shock and burns.
  - The MOSFETs are made of incombustible material. However, if a MOSFET fails, it may emit smoke or flame. Also, operating the MOSFETs near any flammable place or material may cause the MOSFETs to emit smoke or flame in case the MOSFETs become even hotter during operation. Design the arrangement to prevent the spread of fire.
  - The MOSFETs should not used in an environment in the presence of acid, organic matter, or corrosive gas(hydrogen sulfide, sulfurous acid gas etc.)
  - The MOSFETs should not used in an irradiated environment since they are not radiation-proof.

## Installation

Soldering involves temperatures which exceed the device storage temperature rating. To avoid device damage and to ensure reliability, observe the following guidelines from the quality assurance standard.

Solder temperature and duration (through-hole package)

Solder temperature	Duration
260±5 °C	10±1 seconds
350±10 °C	3.5±0.5 seconds

- The immersion depth of the lead should basically be up to the lead stopper and the distance should be a maximum of 1.5mm from the device.
- · When flow-soldering, be careful to avoid immersing the package in the solder bath.

## Recommended soldering condition

MMM	Y.CO.	N Y	MAN TOOK	Methods	W.	V 100Y
Categories	Packages	Wave Soldering (Full dipping)	Wave Soldering (Only terminal)	Infrared Reflow	Air Reflow	Soldering iron (Re-work)
Through-Hole	TO-3PL	×	0	M. XOW.	×	0
MM	TO-3P	×	0	007 ×	×	0
WW	TO-247	×	0	×	×	0
VXX	TO-3PF	×	0	×	×	0
V 1	TO-220	0 ×	0,444	×	×	011
	TO-220F	X	0	×	×	0
	T-Pack(L)	×	0	X	×	0
	TO-3PL-7	×	( O	×	×	0

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• Refer to the following torque reference when mounting the device on a heat sink. Excess torque applied to the mounting screw causes damage to the device and weak torque will increase the thermal resistance, both of which conditions may destroy the device.

Table 1: Recommended tightening torques.

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Package style	Screw	Tightening torques	Note
TO-220 TO-220F	M3	30 – 50 Ncm	flatness : < =±30μm
TO-3P	COM	MMM.	roughness : <=10μm
TO-3PF	M3	40 – 60 Ncm	Plane off the edges :
TO-247		W 100 100	C<=1.0mm
TO-3PL	M3	60 –80 Ncm	WY. COM.TW

- The heat sink should have a flatness within±30µm and roughness within 10µm. Also, keep the tightening torque within the limits of this specification.
- Improper handling may cause isolation breakdown leading to a critical accident.
   ex.) Over plane off the edges of screw hole. (Recommended plane off the edge is C<1.0mm)</li>
- We recommend the use of thermal compound to optimize the efficiency of heat radiation. It is important to evenly apply the compound and to eliminate any air voids.

#### Storage

- The MOSFETs must be stored at a standard temperature of 5 to 35°C and relative humidity of 45 to 75%.
- If the storage area is very dry, a humidifier may be required. In such a case, use only deionized water or boiled water, since the chlorine in tap water may corrode the leads.
- The MOSFETs should not be subjected to rapid changes in temperature to avoid condensation on the surface of the MOSFETs. Therefore store the MOSFETs in a place where the temperature is steady.
- The MOSFETs should not be stored on top of each other, since this may cause excessive external force on the case.
- The MOSFETs should be stored with the lead terminals remaining unprocessed. Rust may cause presoldered connections to fail during later processing.
- The MOSFETs should be stored in antistatic containers or shipping bags.

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#### 11.Appendix

- This products does not contain PBBs (Polybrominated Biphenyl) or PBDEs (Polybrominated Diphenyl Ether), substances.
- This products does not contain Class-I ODS and Class-II ODS substances set force by 'Clean Air Act of US law.
  - · If you have any questions about any part of this Specification, please contact Fuji Electric or its sales agent before using the product.
  - Neither Fuji nor its agents shall be held liable for any injury caused by using the products not in accordance with the instructions.
  - The application examples described in this specification are merely typical uses of Fuji Electric products.
  - This specification does not confer any industrial property rights or other rights, nor constitute a license for such rights.

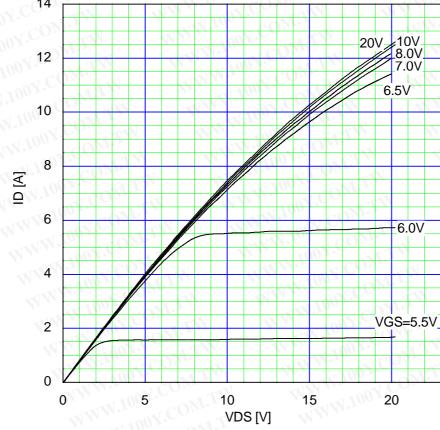
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Allowable Power Dissipation PD=f(Tc)

175
150
125
100
25
0
25
100
125
150
100
125
150

Tc [°C]
Typical Output Characteristics
ID=f(VDS):80 μs pulse test,Tch=25°C



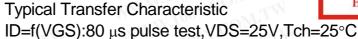
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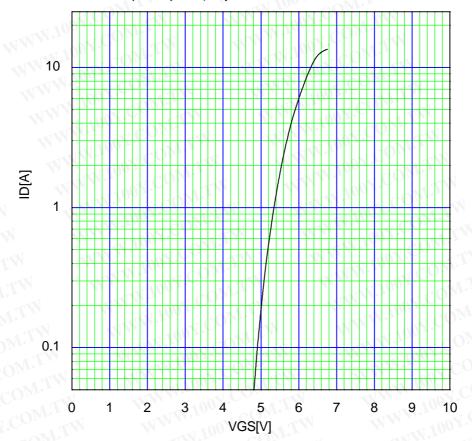
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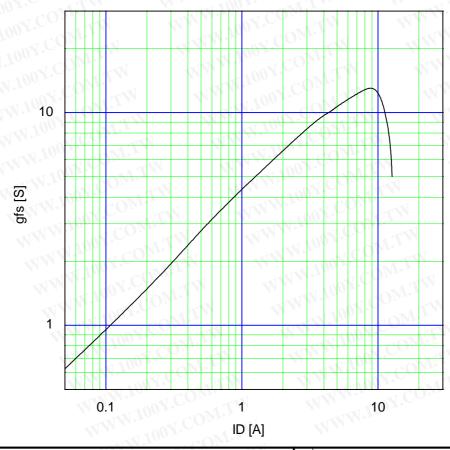
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# Typical Transconductance gfs=f(ID):80 μs pulse test,VDS=25V,Tch=25°C



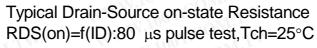
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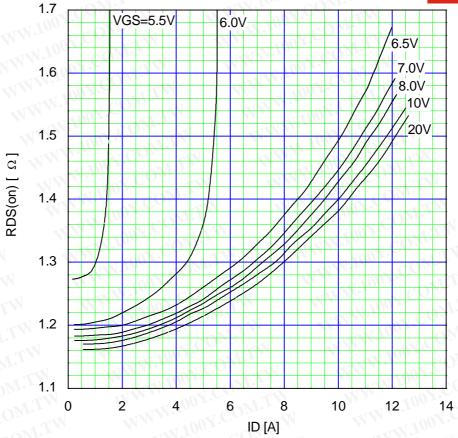
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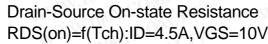
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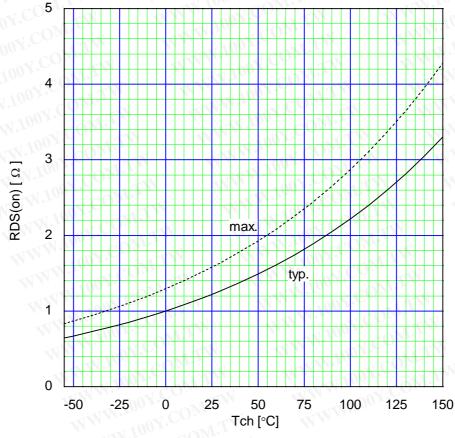
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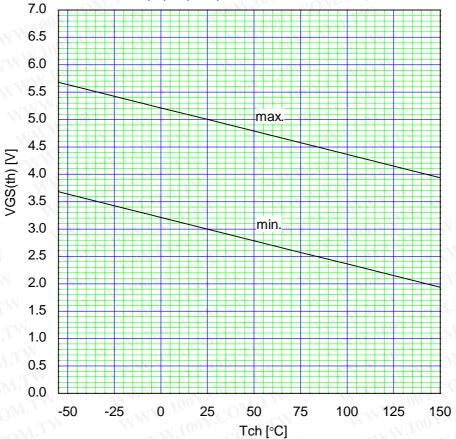
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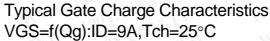
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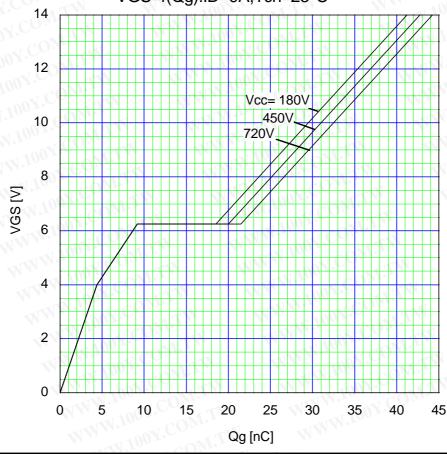
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Gate Threshold Voltage vs. Tch VGS(th)=f(Tch):VDS=VGS,ID=250μA





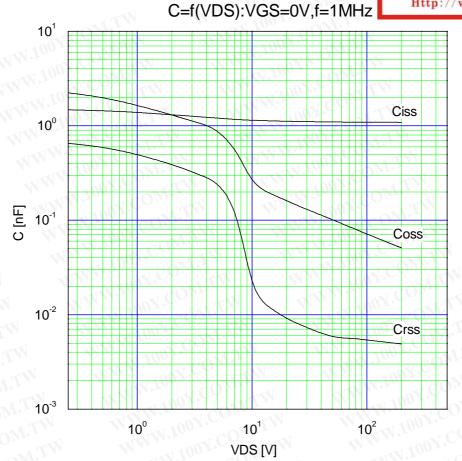


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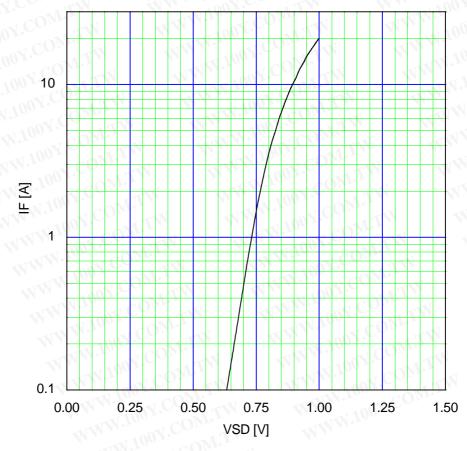
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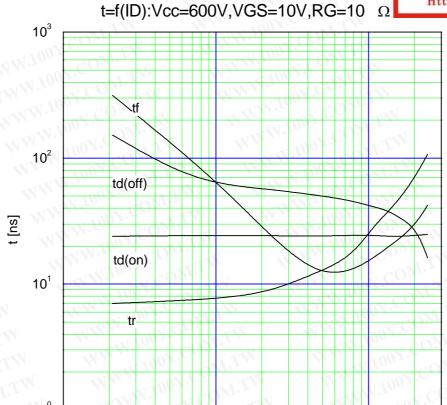
Typical Capacitance

Typical Forward Characteristics of Reverse Diode IF=f(VSD):80 μs pulse test,Tch=25°C



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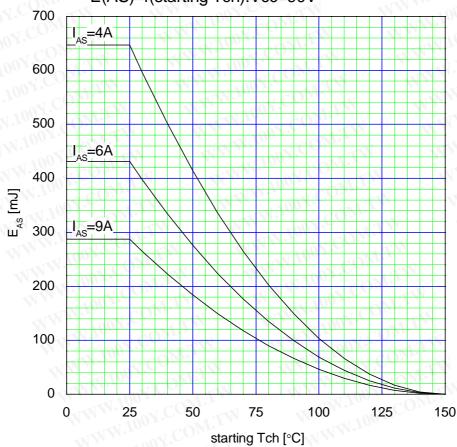


Typical Switching Characteristics vs. ID

Maximum Avalanche Energy vs. starting Tch E(AS)=f(starting Tch):Vcc=90V

ID [A]

10°



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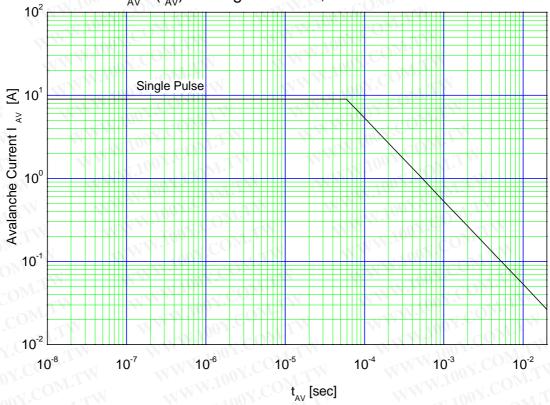
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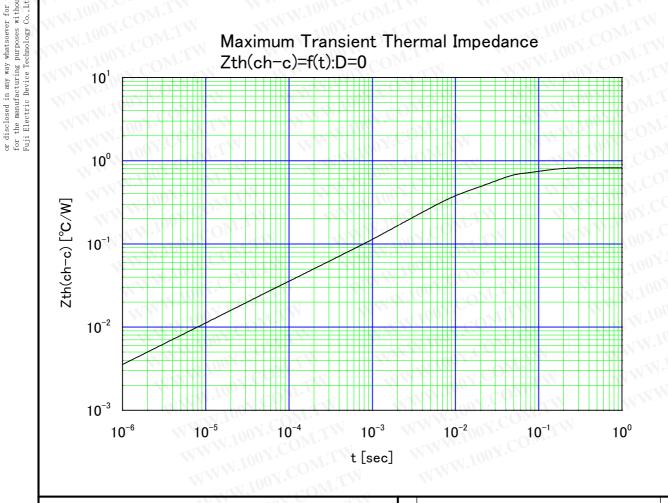
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Maximum Avalanche Current Pulsewidth  $I_{AV}$ = $f(t_{AV})$ :starting Tch=25°C,Vcc=90V





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